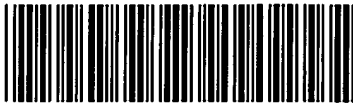


**Search Notes**

Applicant(s)/Patent under R examination

10/771,998

Examiner

Dieu-Minh Le

Applicant(s)/Patent under R examination

NGUYEN ET AL.

Art Unit

2114

**SEARCHED**

Class	Subclass	Date	Examiner
714	42	7/10/2006	DML
714	54		DML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search files USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM-TDB.	7/10/2006	DML
Inventor names search.	7/10/2006	DML